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Application/Control No.	Applicant(s)/Patent under Reexamination					
10/615,899	JANG ET AL					
Examiner	Art Unit					

Michael Kornakov

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Class	Subclass	Date	Examiner
134	22.1,22.18 26,902	7/26/2007	MK
438	905	7/26/2007	мк
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INTERFERENCE SEARCHED						
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SEARCH NOT (INCLUDING SEARCH)
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west (Pre-Grant, USPAT, EPO, JPO, DERWENT)	7/26/2007	МК
Inventors' and assignee search	7/26/2007	МК
NPL search	7/26/2007	мк
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